

An Unlikely Combination of Experiments with a Novel High-Voltage CIGS Photovoltaic Array

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Golden, Colorado

United States of America

4th World Conference on Photovoltaic Energy Conversion

Waikoloa, Hawaii

May 7-12, 2006

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Introduction

- ❑ Long-term (2020) goal of the US Solar Program Multi-Year Plan:
 - Commercialization of photovoltaic (PV) modules with 30-year lifetimes or more, capable of sustaining less than 0.5% annual performance degradation rate, and at costs consistent with market-rates of electricity.
- ❑ Motivation: quantify the performance, stability and reliability of high efficiency thin-film copper-indium-diselenide (CIS) PV modules in a high-voltage array.

Motivation: PV Module Reliability

- High voltage is a known stress-mechanism that precipitates PV module degradation:
 - In the 1980's, the Jet Propulsion Laboratory (JPL) investigated the connection between high-voltage leakage currents from modules and their degradation:
 - Found that series resistance increases, brought about by electrochemical corrosion of contacts, is a prime failure mechanism induced by high-voltage stress
 - Established key thresholds of accumulated charge that would result in 50% failure in certain PV modules:
 - ❖ For crystalline-silicon (c-Si) ranging 1–10 coulombs per linear centimeter (C/cm) of module perimeter,
 - ❖ For amorphous-silicon (a-Si) modules 0.1–1 C/cm

Motivation: PV Performance & Stability

- ❑ Actual energy production of modules under real field conditions continues to be an issue:
 - Currently only measurements of power at Standard Reporting Conditions (SRC) are used to rate modules
 - ❖ But SRC misses most of actual operating conditions
- ❑ PV arrays commonly employ inverters and measurements reported usually include only optimum power-point voltage, current and power
 - When performance degrades, measurements of optimum power point voltage & current are usually not enough to discern the failure mode,
 - Would benefit to have more in-depth I-V characterization.

Goals of This Study

- ❑ Parameterize current-voltage (I-V) performance over a wide range of illumination & temperatures:
 - 50 – 1150 W/m² irradiance, 5° – 65 °C
 - Obtain array temperature coefficients
 - Quantify energy production
- ❑ Investigate high-voltage leakage currents from the CIS modules in a high-voltage array:
 - Determine dependence on moisture, temperature, and voltage bias
 - Ascertain corrosion problems if any
- ❑ Study long-term power & energy production stability.

HVST2 CIGS Array

- 24 Shell Solar thin-film CIGS modules
 - Nominally ± 300 VDC open-circuit & 1 kW total array power
 - Deployed in 2 bipolar strings, 12 modules in each connected in series
 - Each string: aperture area ~ 4.877 m², segregated into 2 groups of 6 modules each group for each string
 - Each group of 6 modules perimeter length ~ 1.915 m
 - Efficiency baseline tested at standard test conditions (STC, η_{STC}) prior to deployment:
 - ❖ All modules tested between 36 and 44 W power, at STC,
 - ❖ Average η_{STC} for the positive (+) and negative (-) strings of the array: respectively, 9.64% and 9.53%.
 - Dry hi-pot and wet hi-pot tests : for both tests, the leakage currents ranged 0.1–0.6 microamps.

HVST2 CIGS Array

Outdoor Test Facility (OTF)

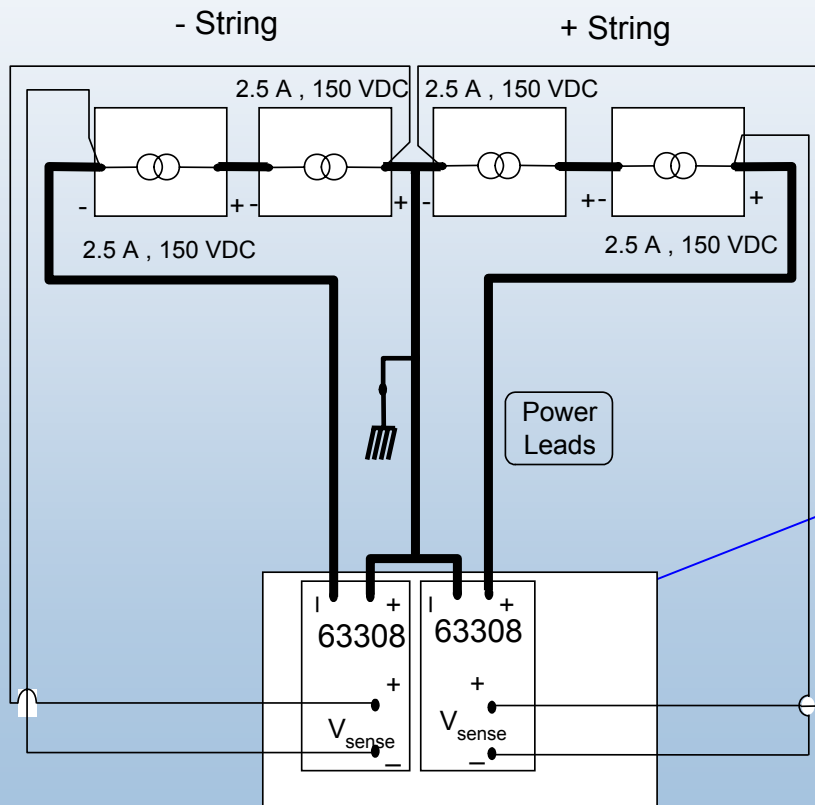
View Looking East Toward Array



- ❑ Current-Voltage (I-V) control & measurements:
 - via programmable e-load
 - I-V traces once every 15min, in 1st quadrant
 - peak-power other times
- ❑ Temperatures:
 - type 'T' TC back-of-module one for each +/- string
 - Air Temp. & humidity (RH)
- ❑ Modules mounted facing south, at $\sim 40^\circ$ tilt \sim latitude $\sim 39.7^\circ$, plane-of-array (POA)
- ❑ Irradiance sensed with pyranometers, same POA

HVST2 Array Connection

High Voltage Array: 24 CIGS PV modules
2 strings + / - , with 12 modules per string,
2 groups of 6 modules in series each,
 ± 300 volts V_{oc} , 2.5 amps I_{sc} from each string



Programmable Electronic Load: Control Modes:
constant current or voltage, resistance Loading

24 CIGS modules in positive (+) and negative (-) strings

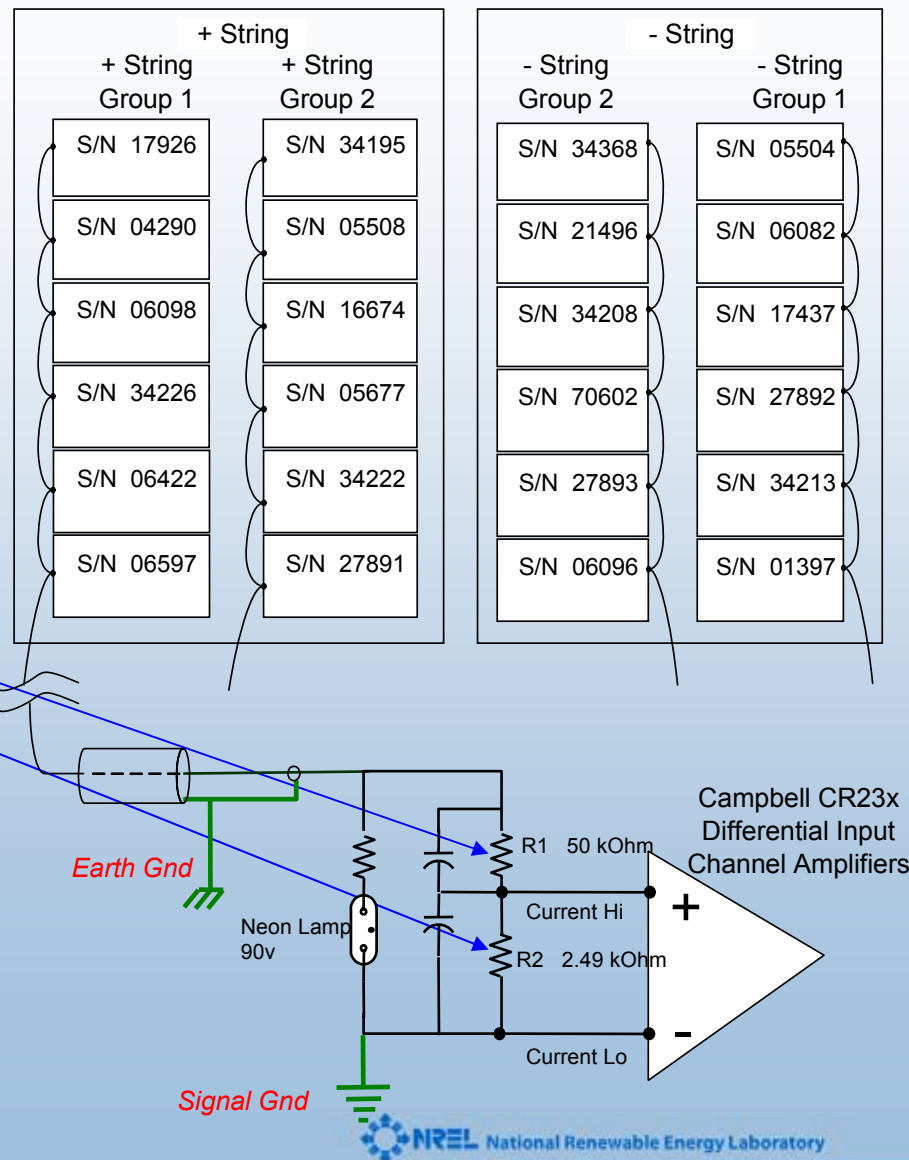
- 12 modules per string, 2 groups of 6 modules each per string
- Frames not grounded at supports, but instead connected to resistive network and then to ground to facilitate leakage current sensing

Electrical Characterization & Control

- via dual-channel Programmable Electronic Load (PEL) interfaced to Data Acquisition System (DAS) running Visual BASIC Code
- PEL is not a power supply/source
- PEL can control in constant voltage, current or resistance
- DAS sends varying set-points to PEL to trace I-V curves or track peak power

HVST2 Array Leakage Currents Sensing

- ❑ Frames allowed to float and electrically daisy-chained together on support structure
- ❑ Electrical connection made to resistive network before ground:
 - Leakage currents pass through 52.5 kOhm resistor combination,
 - Leakage currents appear as voltage across 2.49 kOhm resistor, are sensed by CR23x data-logger differential input channels
 - Arc by-pass to ground provided in case of too much leakage.
- ❑ Each group of 6 modules has own sensing circuit
 - Group 1 always higher offset bias being further from ground

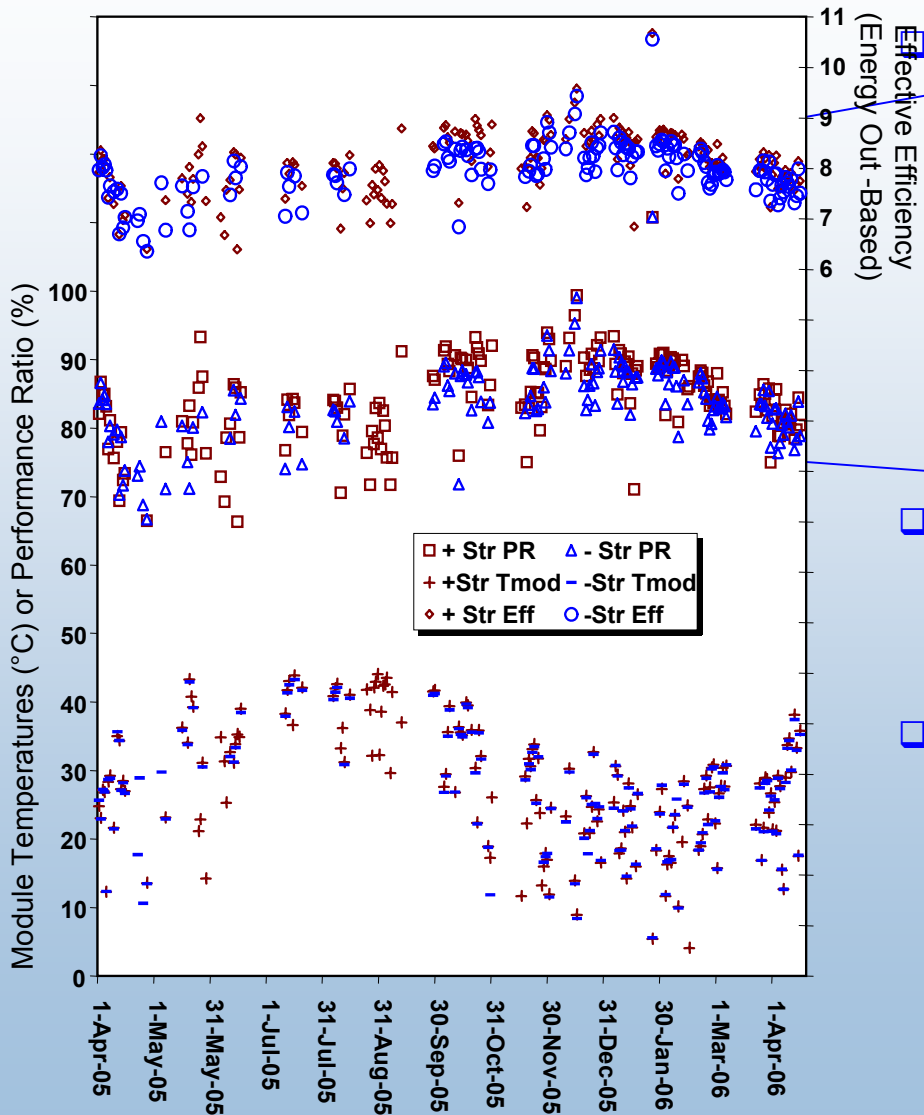


Data Analysis

1. Integration of peak-power tracking and irradiance data versus time yielding daily energy output, insolation
2. Accumulation of all I-V trace records, statistical filtering for predominantly clear-sky conditions, followed by segregation into irradiance bins & regression vs. Temp.
3. Integration of the leakage current data through module frames resulting in accumulated daily leakage charge.
4. Efficiency quotients from two distinct angles:
 - i. usual I-V trace data representing power measurements from each string, divided by the incident power on each string,
 - ii. Effective Efficiency (η_{EFF}) = ratio of the daily energy output from each string divided by the daily insolation energy

$$\eta_{EFF} = \frac{\int_{Daily} P_{MAX} \cdot dt}{[Area_{String} \cdot \int_{Daily} Irr \cdot dt]} \quad (1)$$

Peak Power Tracking Data



Top: Effective efficiency (η_{EFF}) derived daily from energy output (time-integrated power)

- Not temperature corrected due to integration and convolution of all field conditions occurring daily
- Varies seasonally $\sim 7\%$ - $9\frac{1}{2}\%$

Mid: Performance ratio (PR)

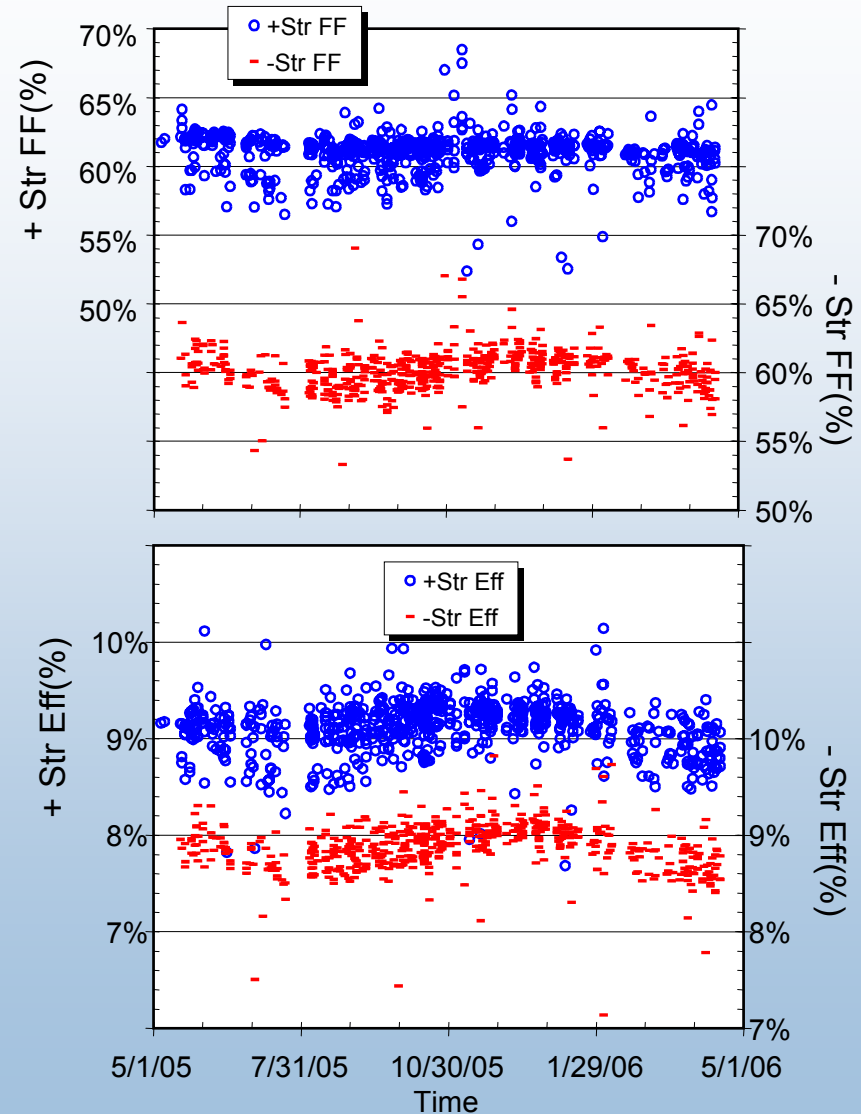
- $PR = \eta_{EFF} / \eta_{STC}$ energy-based, vary 70%-95% of η_{STC}

Bottom: +/- strings sampled average daytime module temperatures

- η_{EFF} is function of temperature,
- $(1 / \eta_{EFF}) d\eta_{EFF} / dT_{air} \sim -0.38\%/^{\circ}C$
 - ❖ $T_{air} \rightarrow$ average daytime air temp.

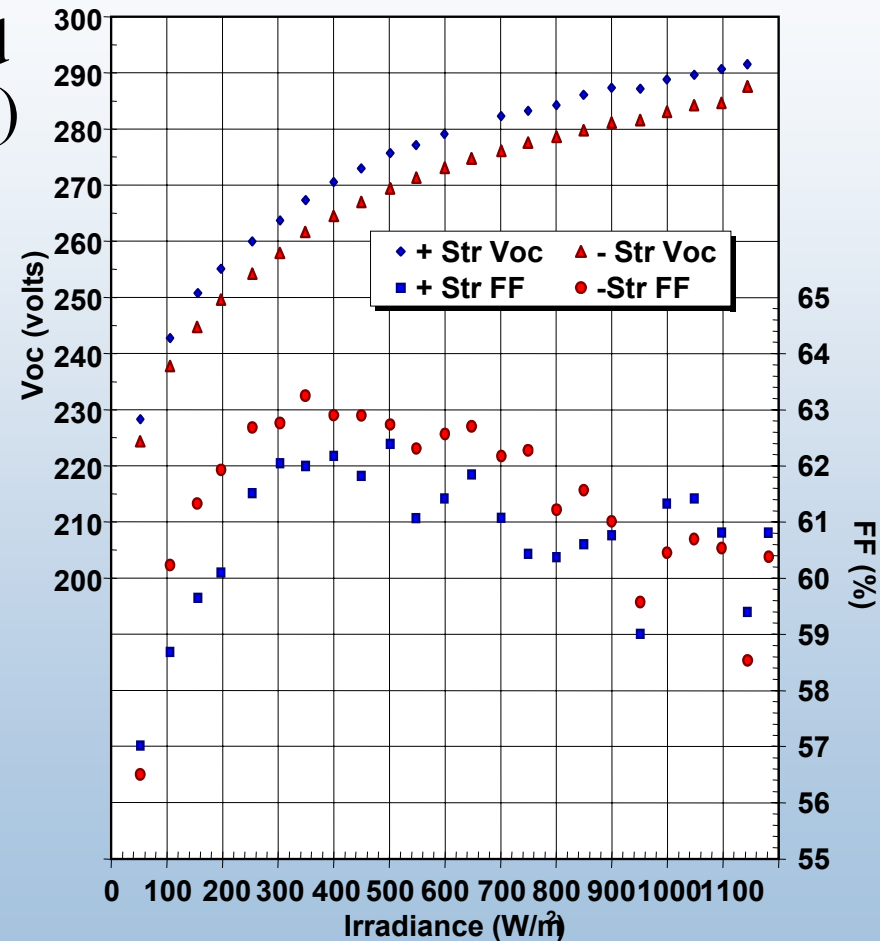
Performance From Full I-V Traces

- FF (top) and Efficiency (bottom) from full I-V traces, corrected to 25°C temperature, for irradiance = $1000 \pm 50 \text{ W/m}^2$ depicted
 - No statistically significant changes in efficiency or FF with time in 1st year
 - Seasonal variations observed
 - + string: $9.1\% \pm 0.3\%$ efficiency, 61%-62% FF
 - - string: $8.9\% \pm 0.3\%$, efficiency, ~60% FF
- Actual FF determination allows closer scrutiny in event of degradation (e.g., series, shunt resistances).

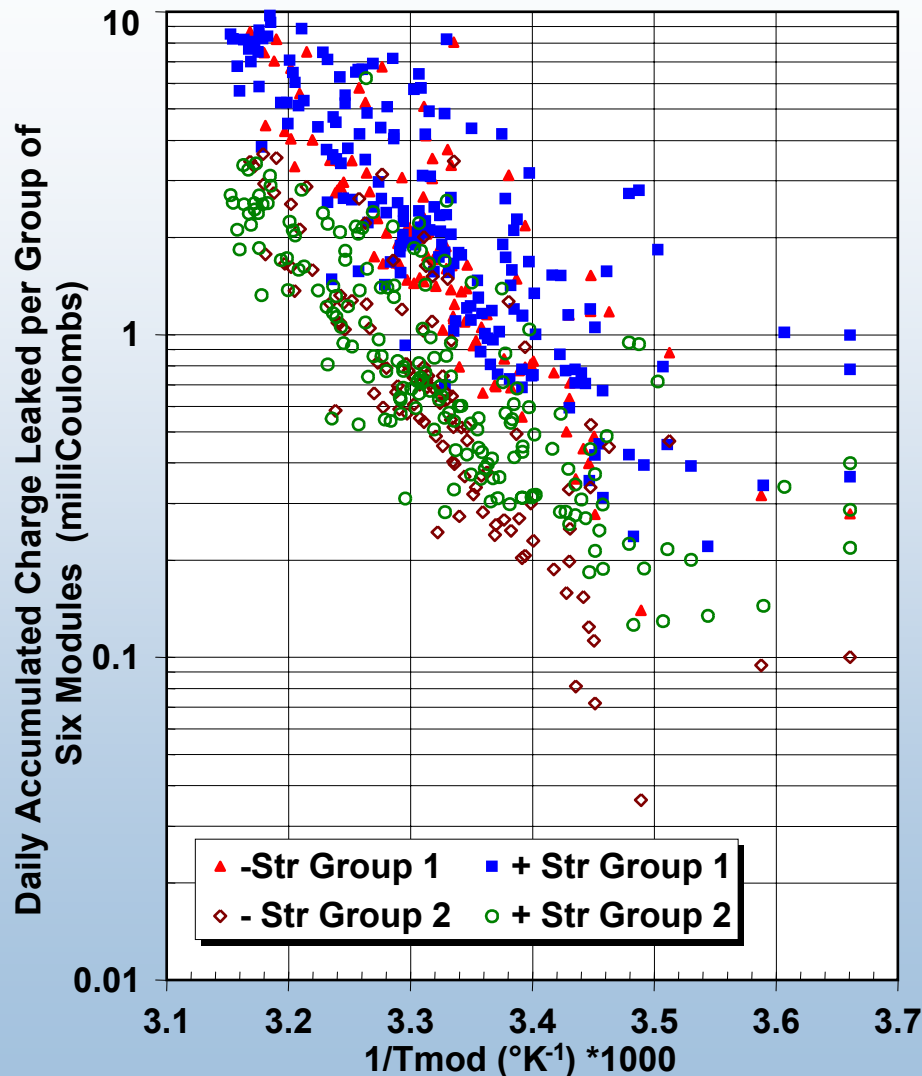


Voc & FF From Full I-V Traces

- Dependence analyzed across all irradiance every 50 W/m², corrected to 25°C module temperature (T_{mod})
 - Voc shows logarithmic type dependence with irradiance
 - ❖ Coefficients $(1/Voc) dVoc/dT_{mod}$ vary ~ -0.37 to -0.30 %/°C
 - FF data, seem to peak at ~ 300 W/m², then decrease with increasing irradiance
 - ❖ Consistent with series-resistance limited behavior
 - ❖ Drops off at low irradiance
 - ❖ Coefficients $(1/FF) dFF/dT_{mod}$ vary ~ -0.05 to $+0.20$ %/°C going from high to low irradiance

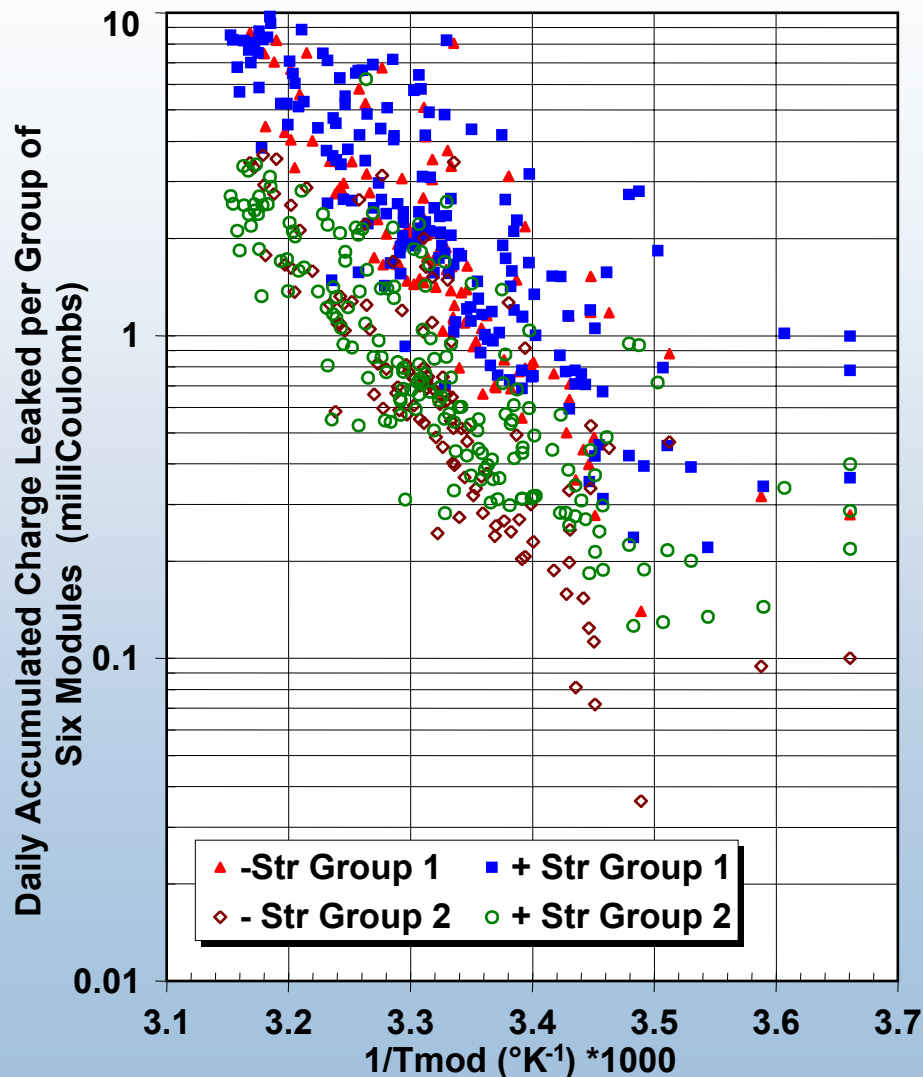


Leakage Currents



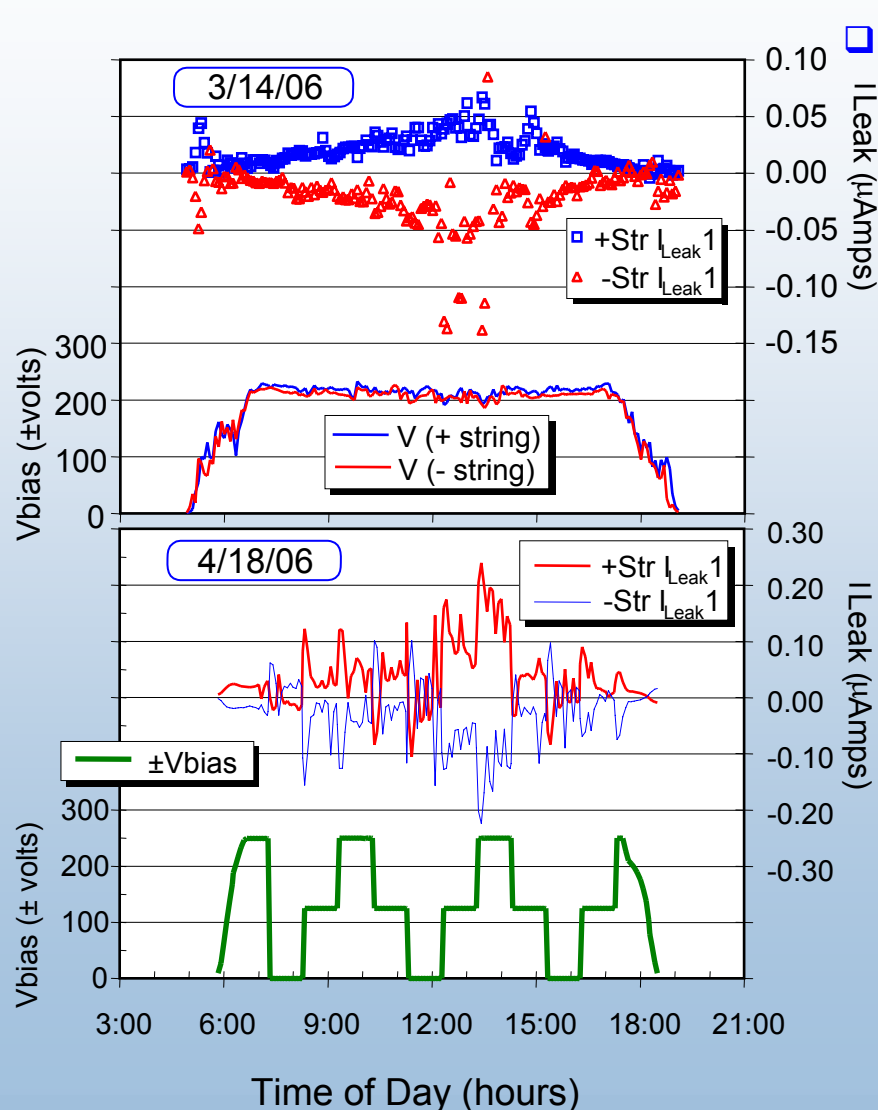
- Q_L = Daily integrated leakage charge: $Q_{Leak} = \int_{Daily} I_{Leak} \cdot dt$
- Computed & plotted for each group of 6 modules vs. average daytime temperatures
- Plotted on Arrhenius Graph
 - Appears thermally activated
 - Scale 0.01-10 milliCoulombs
- Variations or scatter:
 - Sizes of group-1 Q_L are $\sim 2.8 - 2.9$ * Group-2 Q_L , reflects partition of voltages between modules & higher offset bias for group 1
 - Humidity, integration over day convolutes multiple humidity values

Leakage Charge: Activation and Size



- Q_L = integrated leakage charge
- Thermal Activation energies:
 - 0.6-0.78 eV
 - consistent with leakage conduction through soda-lime glass
- For largest leakage ~ 10 mC, T_{mod} average $\sim 23-30^\circ\text{C}$
 - Not a problem in Colorado due to our cold dry climate
 - In hotter climate, say with 200 days/year at these temperatures,
 - ❖ In 10 years, would accumulate ~ 20 Coulombs leakage for each group of 6 modules or about 0.1 C/cm
 - ❖ 0.1 C/cm \Rightarrow is right at threshold for 50% failure rate determined by JPL for a-Si thin-film modules

Leakage Currents: Response to Array Bias



□ Response of high-voltage leakage currents to bias vs. time of day shown for \pm groups 1 on two days

➤ Peak-power tracking at top, & stepped-voltage vs. time profile at bottom,

➤ Corresponding $\pm V_{\text{bias}}$ shown, read at left, leakage currents read at right

➤ For stepped-bias, response appears qualitatively different:

❖ Forcing effect in phase with large step increments in bias

❖ Leakage exhibit transients and larger value by $\sim 2x$ over peak power

❖ Currents actually flip polarity for several minutes when decrementing, but not when incrementing

▪ Ion motion & relaxation in glass

Conclusions

- Performance characterized from both power and energy output considerations:

String	Average Air Temp.	Average Module Temp.	Irradiance or Insolation	Eff (%) Method	PR
+	14	28	6.12 kW-hrs/m ² /day	8.12 Energy	84.3%
+	Temp. Corrected	25	1001.5 Wm ²	9.11 Power	94.5%
-	13	27	6.18 kW-hrs/m ² /day	7.95 Energy	83.5%
-	Temp. Corrected	25	1001.4 Wm ²	8.87 Power	93.1%

- Significance of energy-based effective efficiency, rows 2, 4:
 - ❖ Average insolation * effective efficiency (at 13°-14°C Average daytime air temperature) = delivered energy output per day
 - ❖ We present energy-based performance temperature coefficient:
 - -0.38%/°C vs. average daytime air temperatures

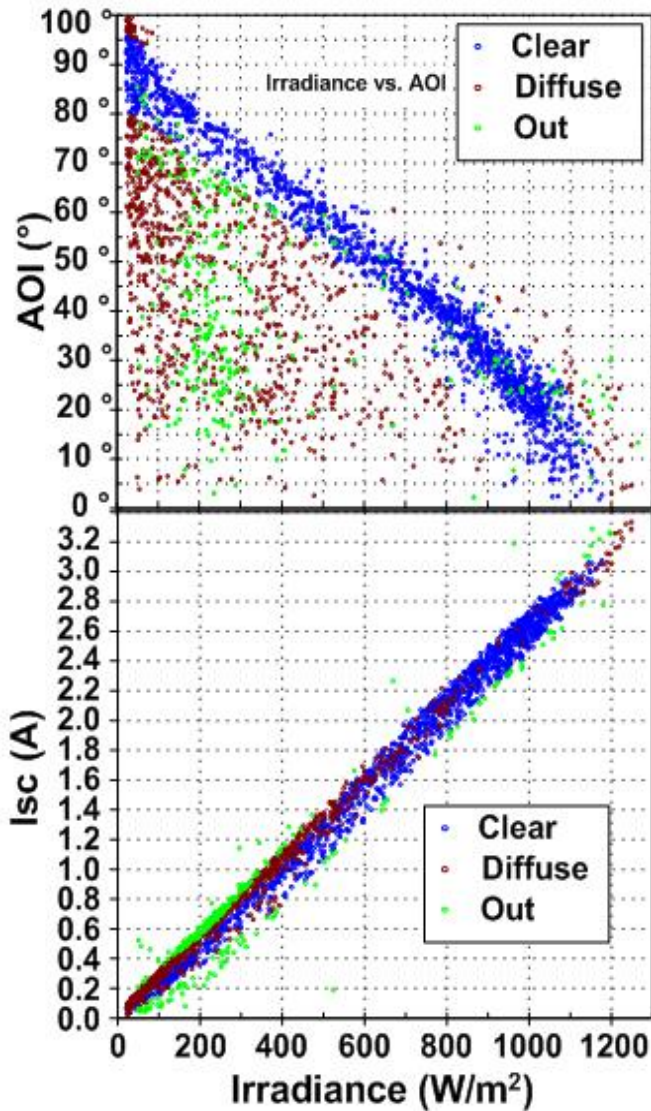
- Stability:

- Does not appear to be degrading statistically or otherwise

Conclusions

- Leakage Currents:
 - Measured and characterized
 - Appear thermally activated
 - May point to potential corrosion problems in hot environments, where average daytime air temperatures are at, or exceed 25-30 °C for 200 days or more per year, after 10 years.

Appendix: IV Trace Statistical Filtering for Clear sky vs. Diffuse Illumination



- Two conditions applied: Isc is linear with Irr & $Irr = Irr(\cos(AOI))$
- $Irr \sim k_2 * \cos(AOI) \pm 2 \sigma$
 - differentiates between predominantly clear vs. diffuse
 - Works well, but at larger AOI the diffuse starts to become dominant over direct beam
- $Isc \sim k_1 * Irr \pm 2 \sigma$
 - mitigates data traced w. rapid changes in Irr and/or obscuration by snow
 - Carried out in piecewise intervals